

<b>INFORMATION DISCLOSURE CITATION</b> <i>(Use several sheets if necessary)</i>	<b>Docket Number (Optional)</b> <b>TWI-5440</b>	<b>Application Number</b> <b>NEW</b>
	<b>Applicant(s)</b> <b>David E. Aspnes et al.</b>	
	<b>Filing Date</b> <b>HEREWITH</b>	<b>Group Art Unit</b> <b>Unknown</b>

**U.S. PATENT DOCUMENTS**

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
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REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

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AS	*BC	A. Ambirajan et al., "Optimum Angles for a Polarimeter: Part I," <i>Optical Engineering</i> , Vol. 34, No. 6, pp. 1651-1655, June 1995.
	*BD	A. Ambirajan et al., "Optimum Angles for a Polarimeter: Part II," <i>Optical Engineering</i> , Vol. 34, No. 6, pp. 1656-1658, June 1995.
	*BE	I. An et al., "Simultaneous Real Time Spectroscopic Ellipsometry and Reflectance for Monitoring Semiconductor and Thin Film Preparation," <i>Materials Research Society Symposium Proc.</i> , Vol. 324, pp. 33-38, 1994.
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<b>Examiner</b> 	<b>Date Considered</b> 1/8/01
<b>Examiner:</b> Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	